


<b>Search Notes</b>  	<b>Application/Control No.</b>  10575738	<b>Applicant(s)/Patent Under Reexamination</b>  ARKNAES-PEDERSEN ET AL.
	<b>Examiner</b>  Khanh V Nguyen	<b>Art Unit</b>  2817

SEARCHED			
Class	Subclass	Date	Examiner
330	10,207A,251	8/27/2008	NKV

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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